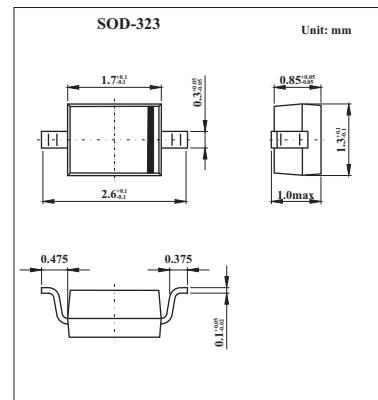


**General Purpose PIN Diode****BAP1321-03****■ Features**

- High voltage, current controlled
- RF resistor for RF attenuators and switches
- Low diode capacitance
- Low diode forward resistance
- Very low series inductance
- For applications up to 3 GHz.

**■ Absolute Maximum Ratings Ta = 25°C**

Parameter	Symbol	Rating	Unit
Continuous reverse voltage	V <sub>R</sub>	60	V
Continuous forward current	I <sub>F</sub>	100	mA
Total power dissipation Ts = 90°C	P <sub>tot</sub>	500	mW
Storage temperature	T <sub>stg</sub>	-65 to +150	°C
Junction temperature	T <sub>j</sub>	150	°C
Thermal resistance from junction to soldering point	R <sub>th(j-s)</sub>	120	°C/W

**BAP1321-03**■ Electrical Characteristics  $T_a = 25^\circ C$ 

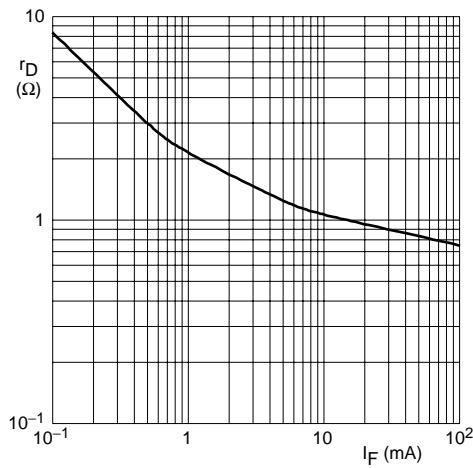
Parameter	Symbol	Test conditons	Min	Typ	Max	Unit
Forward voltage	$V_F$	$I_F = 50 \text{ mA}$		0.95	1.1	V
Reverse current	$I_R$	$V_R = 60 \text{ V}$		100		nA
Diode capacitance	$C_d$	$V_R = 0; f = 1 \text{ MHz}$		0.4		pF
		$V_R = 1 \text{ V}; f = 1 \text{ MHz}$		0.35	0.45	pF
		$V_R = 20 \text{ V}; f = 1 \text{ MHz}$		0.25	0.32	pF
Diode forward resistance	$r_D$	$I_F = 0.5 \text{ mA}; f = 100 \text{ MHz}$		3.4	5	$\Omega$
		$I_F = 1 \text{ mA}; f = 100 \text{ MHz}$		2.4	3.6	$\Omega$
		$I_F = 10 \text{ mA}; f = 100 \text{ MHz}$		1.2	1.8	$\Omega$
		$I_F = 100 \text{ mA}; f = 100 \text{ MHz}$		0.85	1.3	$\Omega$
isolation	$ S_{21} ^2$	$V_R = 0; f = 900 \text{ MHz}$		16.6		dB
		$V_R = 0; f = 1800 \text{ MHz}$		11.6		dB
		$V_R = 0; f = 2450 \text{ MHz}$		9.2		dB
insertion loss	$ S_{21} ^2$	$V_R = 0.5\text{mA}; f = 900 \text{ MHz}$		0.26		dB
		$V_R = 0.5\text{mA}; f = 1800 \text{ MHz}$		0.35		dB
		$V_R = 0.5\text{mA}; f = 2450 \text{ MHz}$		0.44		dB
insertion loss	$ S_{21} ^2$	$V_R = 1\text{mA}; f = 900 \text{ MHz}$		0.2		dB
		$V_R = 1\text{mA}; f = 1800 \text{ MHz}$		0.29		dB
		$V_R = 1\text{mA}; f = 2450 \text{ MHz}$		0.38		dB
insertion loss	$ S_{21} ^2$	$V_R = 10\text{mA}; f = 900 \text{ MHz}$		0.13		dB
		$V_R = 10\text{mA}; f = 1800 \text{ MHz}$		0.22		dB
		$V_R = 10\text{mA}; f = 2450 \text{ MHz}$		0.32		dB
insertion loss	$ S_{21} ^2$	$V_R = 100\text{mA}; f = 900 \text{ MHz}$		0.1		dB
		$V_R = 100\text{mA}; f = 1800 \text{ MHz}$		0.2		dB
		$V_R = 100\text{mA}; f = 2450 \text{ MHz}$		0.29		dB
charge carrier life time	$\tau_L$	When switched from $I_F = 10 \text{ mA}$ to $I_R = 6 \text{ mA}; R_L = 100 \Omega;$ measured at $I_R = 3 \text{ mA}$		0.5		$\mu\text{s}$
series inductance	$L_s$	$I_F = 100 \text{ mA}; f = 100 \text{ MHz}$		1.5		nH

## ■ Marking

Marking	V8
---------	----

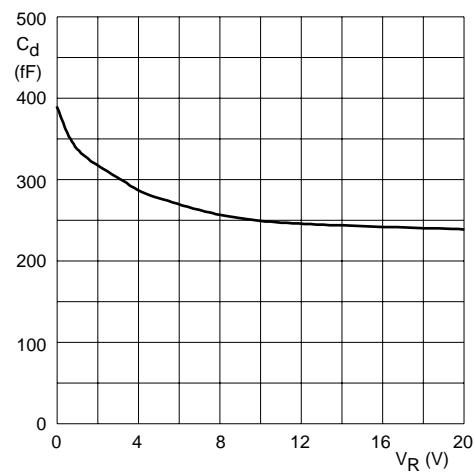
**BAP1321-03**

## ■ Typical Characteristics



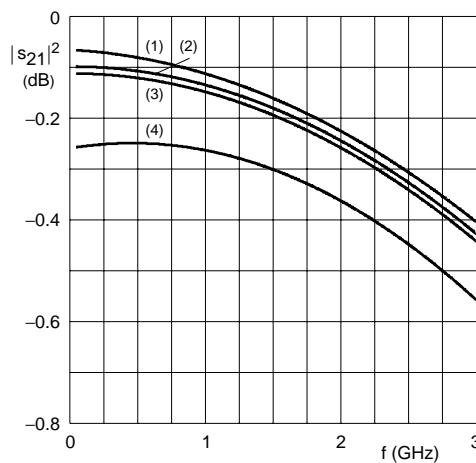
$T_j = 25^\circ\text{C}; f = 100 \text{ MHz}.$

Fig.1 Forward resistance as a function of the forward current; typical values.



$T_j = 25^\circ\text{C}; f = 1 \text{ MHz}.$

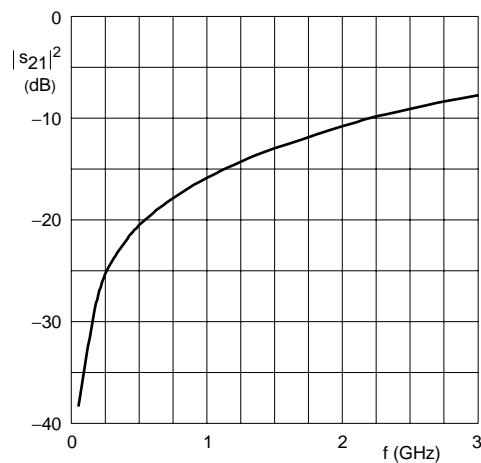
Fig.2 Diode capacitance as a function of reverse voltage; typical values.



(1)  $I_F = 100 \text{ mA}$ .      (3)  $I_F = 1 \text{ mA}$ .  
 (2)  $I_F = 10 \text{ mA}$ .      (4)  $I_F = 0.5 \text{ mA}$ .

Diode inserted in series with a  $50 \Omega$  stripline circuit  
and biased via the analyzer Tee network.  
 $T_{\text{amb}} = 25^\circ\text{C}$ .

Fig.3 Insertion loss ( $|S_{21}|^2$ ) of the diode in on-state as a function of frequency; typical values.



Diode zero biased and inserted in series with a  $50 \Omega$  stripline circuit.  
 $T_{\text{amb}} = 25^\circ\text{C}$ .

Fig.4 Isolation ( $|S_{21}|^2$ ) of the diode in off-state as a function of frequency; typical values.